INTEGRATED CIRCUITS

DATA SHEET



74HC1G66; **74HCT1G66** Bilateral switch

Product specification Supersedes data of 2001 Mar 02





Bilateral switch

74HC1G66; 74HCT1G66

FEATURES

- Wide operating voltage range from 2.0 to 9.0 V
- Very low ON-resistance:
 - -45Ω (typical) at $V_{CC} = 4.5 V$
 - -30Ω (typical) at $V_{CC} = 6.0 V$
 - 25 Ω (typical) at $V_{CC} = 9.0 \text{ V}$.
- · High noise immunity
- · Low power dissipation
- · Very small 5 pins package
- · Output capability: non standard.

DESCRIPTION

The 74HC1G/HCT1G66 is a high-speed Si-gate CMOS device.

The 74HC1G/HCT1G66 provides an analog switch. The switch has two input/output pins (Y and Z) and an active HIGH enable input pin (E). When pin E is LOW, the analog switch is turned off.

The non standard output currents are equal compared to the 74HC/HCT4066.

QUICK REFERENCE DATA

GND = 0 V; T_{amb} = 25 °C; t_r = t_f = 6.0 ns.

SYMBOL	PARAMETER	CONDITIONS	TYP	UNIT	
STIVIBUL	PARAMETER	CONDITIONS	HC1G	HCT1G	01411
t _{PZH} /t _{PZL}	turn-on time E to Vos	$C_L = 15 \text{ pF}; R_L = 1 \text{ k}\Omega; V_{CC} = 5 \text{ V}$	11	12	ns
t _{PHZ} /t _{PLZ}	turn-off time E to Vos	$C_L = 15 \text{ pF}; R_L = 1 \text{ k}\Omega; V_{CC} = 5 \text{ V}$	11	12	ns
C _I	input capacitance	CO.	1.5	1.5	pF
C _{PD}	power dissipation capacitance	notes 1 and 2	9	9	pF
C _S	maximum switch capacitance		8	8	pF

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum ((C_L + C_S) \times V_{CC}^2 \times f_o)$$
 where:

 f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

C_S = maximum switch capacitance in pF;

V_{CC} = supply voltage in Volts;

 $\sum ((C_L + C_S) \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$

2. For HC1G the condition is $V_I = GND$ to V_{CC} .

For HCT1G the condition is $V_I = GND$ to $V_{CC} - 1.5 V$.

FUNCTION TABLE

See note 1.

INPUT E	SWITCH
L	OFF
Н	ON

Note

- 1. H = HIGH voltage level;
 - L = LOW voltage level.

Bilateral switch

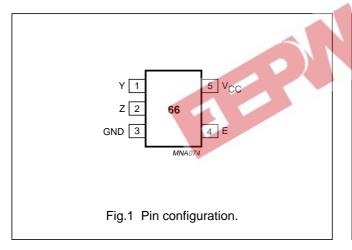
74HC1G66; 74HCT1G66

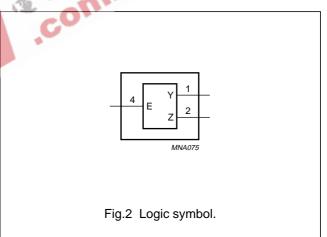
ORDERING INFORMATION

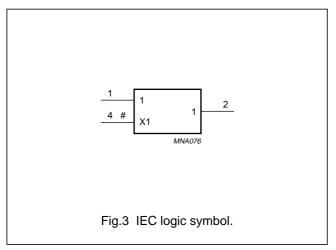
OUTSIDE NORTH	PACKAGE									
AMERICA	TEMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE	MARKING				
74HC1G66GW	-40 to +125 °C	5	SC-88A	plastic	SOT353	HL				
74HCT1G66GW	-40 to +125 °C	5	SC-88A	plastic	SOT353	TL				
74HC1G66GV	-40 to +125 °C	5	SC-74A	plastic	SOT753	H66				
74HCT1G66GV	-40 to +125 °C	5	SC-74A	plastic	SOT753	T66				

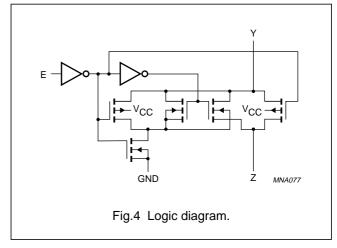
PINNING

PIN	SYMBOL	DESCRIPTION
1	Υ	independent input/output Y
2	Z	independent input/output Z
3	GND	ground (0 V)
4	E	enable input E (active HIGH)
5	V _{CC}	supply voltage









Bilateral switch

74HC1G66; 74HCT1G66

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	74HC1G66			74HCT1G66			UNIT
STINIBUL			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	UNIT
V _{CC}	supply voltage		2.0	5.0	10.0	4.5	5.0	5.5	V
V _I	input voltage		GND	_	V _{CC}	GND	_	V _{CC}	V
Vs	switch voltage		GND	_	V _{CC}	GND	_	V _{CC}	V
T _{amb}	operating ambient temperature	see DC and AC characteristics per device	-40	_	+125	-40	_	+125	°C
t _r , t _f	input rise and fall times	V _{CC} = 2.0 V	_	_	1000	_	_	_	ns
		V _{CC} = 4.5 V	_	6.0	500	_	6.0	500	ns
		V _{CC} = 6.0 V	_	_	400	_	_	_	ns
		V _{CC} = 10.0 V	_	_	250	_	_	_	ns

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V); see note 1.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
OTHIBOL	TANAMETER	CONBITION	141114.	WIAA.	0.4
V_{CC}	supply voltage	C	-0.5	+11.0	V
I _{IK}	input diode current	$V_1 < -0.5 \text{ V or } V_1 > V_{CC} + 0.5 \text{ V}$	_	±20	mA
I _{SK}	switch diode current	$V_{S} < -0.5 \text{ V or } V_{S} > V_{CC} + 0.5 \text{ V}$	_	±20	mA
I _S	switch source or sink current	$-0.5 \text{ V} < \text{V}_{\text{S}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	_	±25	mA
I _{CC}	V _{CC} or GND current		_	±50	mA
T _{stg}	storage temperature		-65	+150	°C
P_D	power dissipation per package	for temperature range from –40 to + 125 °C; note 2	_	200	mW
Ps	power dissipation per switch		_	100	mW

Notes

- To avoid drawing V_{CC} current out of pin Z, when switch current flows in pin Y, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into pin Z, no V_{CC} current will flow out of terminal Y. In this case there is no limit for the voltage drop across the switch, but the voltage at pins Y and Z may not exceed V_{CC} or GND.
- 2. Above 55 °C the value of P_D derates linearly with 2.5 mW/K.

Bilateral switch

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DC CHARACTERISTICS

Family 74HC1G66

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

		TEST CONDITION	NS	T _{amb} (°C)					
SYMBOL	PARAMETER	OTHER	V 00	−40 to +85			-40 to +125		UNIT
		OTTER	V _{CC} (V)	MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{IH}	HIGH-level input		2.0	1.5	1.2	_	1.5	-	V
	voltage		4.5	3.15	2.4	_	3.15	-	V
			6.0	4.2	3.2	_	4.2	_	V
			9.0	6.3	4.7	_	6.3	_	V
V_{IL}	LOW-level input		2.0	_	8.0	0.5	_	0.5	V
	voltage		4.5	_	2.1	1.35	_	1.35	V
			6.0	_	2.8	1.8	_	1.8	V
			9.0	_	4.3	2.7	_	2.7	V
ILI	input leakage	$V_I = V_{CC}$ or GND	6.0	- 300	0.1	1.0	_	1.0	μΑ
	current		10.0	~ 有	0.2	2.0	_	2.0	μΑ
I _S	analog switch current, OFF-state	$V_I = V_{IH}$ or V_{IL} ; $ V_S = V_{CC} - GND$; see Fig.6	10.0	CO	0.1	1.0	_	1.0	μΑ
	analog switch current, ON-state	$V_I = V_{IH}$ or V_{IL} ; $ V_S = V_{CC} - GND$; see Fig.7	10.0	•	0.1	1.0	_	1.0	μΑ
I _{CC}	quiescent supply	$V_I = V_{CC}$ or GND;	6.0	_	1.0	10	_	20	μΑ
	current	$V_{is} = GND \text{ or } V_{CC};$ $V_{os} = V_{CC} \text{ or } GND$	10.0	_	2.0	20	_	40	μΑ

Note

1. All typical values are measured at T_{amb} = 25 °C.

Bilateral switch

74HC1G66; 74HCT1G66

Family 74HCT1G66

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

		TEST CONDITI	IONS	T _{amb} (°C)					
SYMBOL	PARAMETER	OTHER	V 00	−40 to +85			-40 to +125		UNIT
		OTHER	V _{CC} (V)	MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{IH}	HIGH-level input voltage		4.5 to 5.5	2.0	1.6	_	2.0	_	V
V _{IL}	LOW-level input voltage		4.5 to 5.5	0.1	1.2	0.8	_	0.8	V
ILI	input leakage current	$V_I = V_{CC}$ or GND	5.5	_	0.1	1.0	_	1.0	μΑ
I _S	analog switch current, OFF-state	$V_I = V_{IH}$ or V_{IL} ; $ V_S = V_{CC} - GND$; see Fig.6	5.5	_	0.1	1.0	_	1.0	μΑ
	analog switch current, ON-state	$V_I = V_{IH} \text{ or } V_{IL};$ $ V_S = V_{CC} - \text{GND};$ see Fig.7	5.5	_	0.1	1.0	_	1.0	μΑ
Icc	quiescent supply current	$V_I = V_{CC}$ or GND; $V_{is} = GND$ or V_{CC} ; $V_{os} = V_{CC}$ or GND	4.5 to 5.5	13	16 /h	10	_	20	μΑ
ΔI_{CC}	additional supply current per input	$V_{I} = V_{CC} - 2.1 \text{ V}$	4.5 to 5.5	OL	7	500	_	850	μΑ

Note

1. All typical values are measured at T_{amb} = 25 °C.

Bilateral switch

74HC1G66; 74HCT1G66

Family 74HC1G66 and 74HCT1G66

For 74HC1G66: $V_{CC} = 2.0, 4.5, 6.0 \text{ or } 9.0 \text{ V}$; note 1.

For 74HCT1G66: $V_{CC} = 4.5 \text{ V}$.

		TEST CONDITIONS				T _{amb} (°C)				
SYMBOL	PARAMETER	OTHER	V _{CC} (V)	I _S (μ A)	−40 to +85			-40 to +125		UNIT
		OTHER			MIN.	TYP. ⁽²⁾	MAX.	MIN.	MAX.	
R _{ON}	ON-resistance	$V_{is} = V_{CC}$ to GND;	2.0	100	_	_	_	_	_	Ω
	(peak)	$V_I = V_{IH}$ or V_{IL} ;	4.5	1000	_	42	118	_	142	Ω
	see Fig.5	6.0	1000	_	31	105	_	126	Ω	
			9.0	1000	_	23	88	_	105	Ω
	ON-resistance	V _{is} = GND;	2.0	100	_	75	_	_	_	Ω
	(rail)	$V_I = V_{IH}$ or V_{IL} ;	4.5	1000	_	29	95	_	115	Ω
		see Fig.5	6.0	1000	_	23	82	_	100	Ω
			9.0	1000	_	18 🐠	70	_	80	Ω
		$V_{is} = V_{CC};$	2.0	100	- 4	75	_	_	_	Ω
		$V_I = V_{IH} \text{ or } V_{IL};$	4.5	1000	-36.3	35	106	_	128	Ω
		see Fig.5	6.0	1000	-	27	94	_	113	Ω
			9.0	1000	±0//	21	78	_	95	Ω

Notes

1. At supply voltages approaching 2 V, the analog switch ON-resistance becomes extremely non-linear. Therefore it is recommended that these devices be used to transmit digital signals only, when using this supply voltage.

2. All typical values are measured at $T_{amb} = 25$ °C.

Bilateral switch

74HC1G66; 74HCT1G66

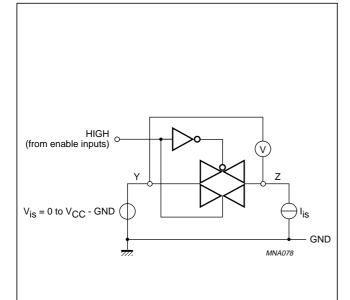
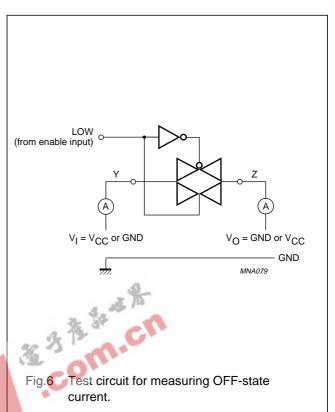
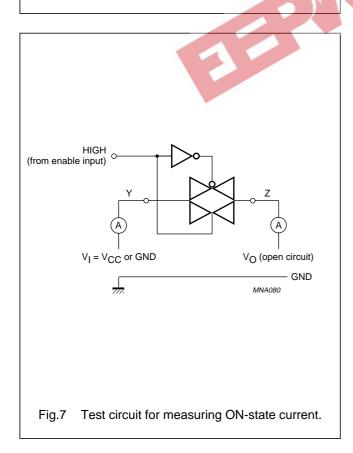
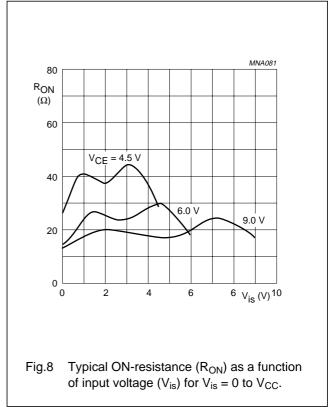


Fig.5 Test circuit for measuring ON-resistance (R_{ON}).







Bilateral switch

74HC1G66; 74HCT1G66

AC CHARACTERISTICS

Type 74HC1G66

 $GND = 0 V; t_r = t_f = 6 ns.$

		TEST CONDITIO	NS						
SYMBOL	PARAMETER	WAVEFORMS	V _{CC} (V)	−40 to +85			−40 to +125		UNIT
		WAVEFORWIS		MIN.	TYP. (1)	MAX.	MIN.	MAX.	
t _{PHL} /t _{PLH}	propagation delay	$R_L = \infty$; $C_L = 50 \text{ pF}$;	2.0	_	8	75	_	90	ns
	V _{is} to V _{os}	see Fig.12	4.5	_	3	15	_	18	ns
			6.0	_	2	13	_	15	ns
				_	1	10	_	12	ns
t _{PZH} /t _{PZL}	turn-on time	$R_L = 1 \text{ k}\Omega; C_L = 50 \text{ pF}; 2.0$	2.0	_	50	125	_	150	ns
	E to V _{os}	see Figs 13 and 14	4.5	_	16	25	_	30	ns
			6.0	_	13	21	_	26	ns
			9.0	_	9	16	_	20	ns
t _{PHZ} /t _{PLZ}	turn-off time	$R_L = 1 \text{ k}\Omega; C_L = 50 \text{ pF}:$	2.0	- 38	27	190	_	225	ns
	E to V _{os}	see Figs 13 and 14	4.5	2 13	16	38	_	45	ns
			6.0	₹	14	33	_	38	ns
			9.0	70	12	16	_	20	ns

Note

1. All typical values are measured at $T_{amb} = 25$ °C.

Type 74HCT1G66

GND = 0 V; $t_r = t_f = 6$ ns; V_{is} is the input voltage at pins Y or Z, whichever is assigned as an input. V_{os} is the output voltage at pins Y or Z, whichever is assigned as an output.

	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					
SYMBOL		WAVEFORMS	V _{CC} (V)	−40 to +85			−40 to +125		UNIT
				MIN.	TYP.(1)	MAX.	MIN.	MAX.	
t _{PHL} /t _{PLH}	propagation delay V _{is} to V _{os}	$R_L = \infty$; $C_L = 50 \text{ pF}$; see Fig.12.	4.5	_	3	15	_	18	ns
t _{PZH} /t _{PZL}	turn-on time E to V _{os}	$R_L = 1 \text{ k}\Omega; C_L = 50 \text{ pF};$ see Figs 15 and 16.	4.5	_	15	30	_	36	ns
t _{PHZ} /t _{PLZ}	turn-off time E to V _{os}	$R_L = 1 \text{ k}\Omega; C_L = 50 \text{ pF};$ see Figs 15 and 16.	4.5	_	13	44	_	53	ns

Note

1. All typical values are measured at T_{amb} = 25 °C.

Bilateral switch

74HC1G66; 74HCT1G66

Type 74HC1G66 and 74HCT1G66

At recommended conditions and typical values. GND = 0 V; $t_r = t_f = 6.0$ ns. V_{is} is the input voltage at pins Y or Z, whichever is assigned as an input; V_{os} is the output voltage at pins Y or Z, whichever is assigned as an output.

SYMBOL	PARAMETER	TEST CONDITIONS	V _{is(p-p)} (V)	V _{CC} (V)	TYP.	UNIT
	sine-wave distortion	$R_L = 10 \text{ k}\Omega; C_L = 50 \text{ pF}; \text{ see Fig.12}$	4.0	4.5	0.04	%
	f = 1 kHz		8.0	9.0	0.02	%
	sine-wave distortion	$R_L = 10 \text{ k}\Omega; C_L = 50 \text{ pF}; \text{ see Fig.12}$	4.0	4.5	0.12	%
	f = 10 kHz		8.0	9.0	0.06	%
	switch OFF signal	$R_L = 600 \Omega$; $C_L = 50 pF$; $f = 1 MHz$;	note 1	4.5	-50	dB
	feed-through	see Figs 9 and 13		9.0	-50	dB
f _{max}	minimum frequency	$R_L = 50 \Omega; C_L = 10 pF;$	note 2	4.5	180	MHz
	response (–3 dB)	see Figs 10 and 11		9.0	200	MHz
Cs	maximum switch capacitance				8	pF

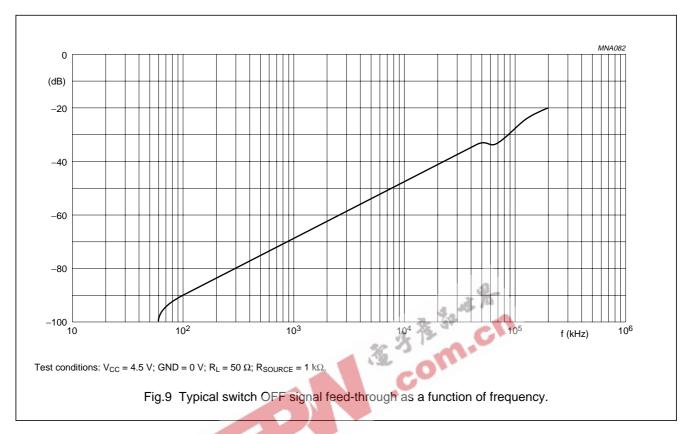
Notes

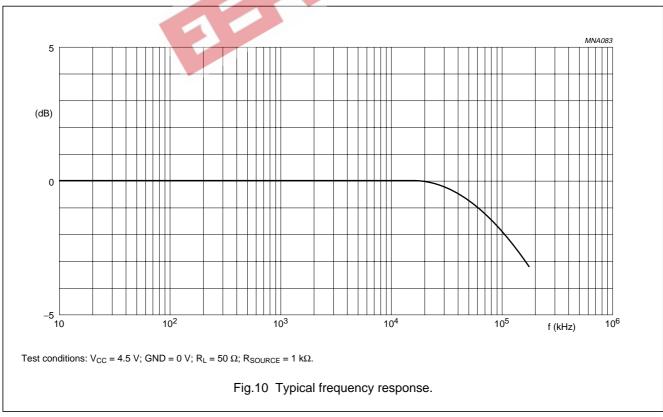
- Adjust input voltage V_{is} is 0 dBm level (0 dBM = 1 mW into 600 Ω).
 Adjust input voltage V_{is} is 0 dBm level at V_{os} for 1 MHz (0 dBM = 1 mW into 50 Ω).



Bilateral switch

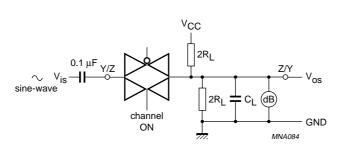
74HC1G66; 74HCT1G66





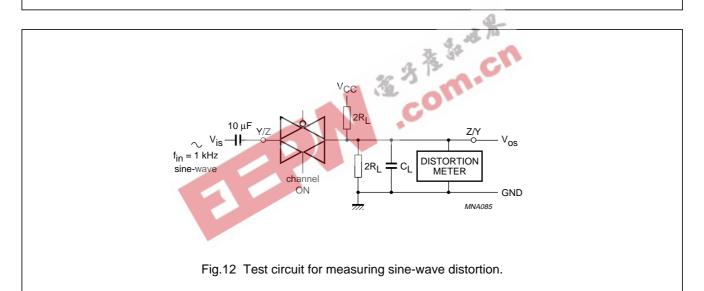
Bilateral switch

74HC1G66; 74HCT1G66



Adjust input voltage to obtain 0 dBm at V_{os} when f_{in} = 1 MHz. After set-up, frequency of f_{in} is increased to obtain a reading of -3 db at V_{os} .

Fig.11 Test circuit for measuring minimum frequency response.



$$\begin{array}{c} V_{CC} \\ V_{is} & \\ \hline \end{array}$$

$$\begin{array}{c} V_{CC} \\ V_{is} & \\ \hline \end{array}$$

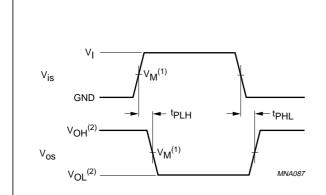
$$\begin{array}{c} V_{CC} \\ V_{OS} \\ \hline \end{array}$$

$$\begin{array}{c} V_{CC} \\ V_{CC} \\ \hline \end{array}$$

Bilateral switch

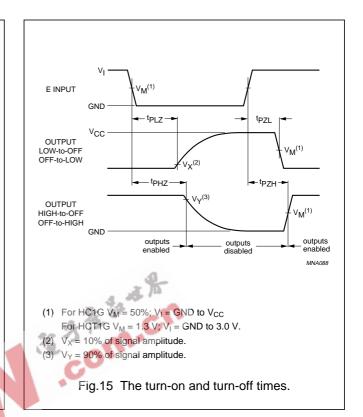
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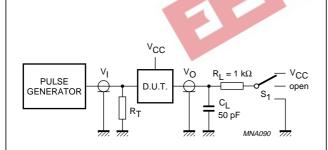
AC WAVEFORMS



- (1) For HC1G $V_M = 50\%$ For HCT1G $V_M = 1.3 V$.
- 2) V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

Fig.14 The input (V_{is}) to output (V_{os}) propagation delays.





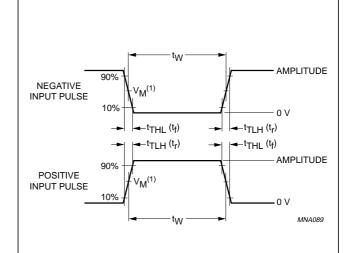
Definitions for test circuit:

 C_L = load capacitance including jig and probe capacitance (see "AC characteristics" for values)

 $R_{T}\!=\!$ termination resistance should be equal to the output impedance Z_{o} of the pulse generator.

TEST	S ₁
t _{PLH} /t _{PHL}	open
t _{PLZ} /t _{PZL}	V_{CC}
t _{PHZ} /t _{PZH}	GND

Fig.16 Test circuit for measuring AC performance.



 t_{r} = t_{f} = 6 ns, when measuring $f_{max},$ there is no constraint on $t_{r},\,t_{f}$ with 50% duty factor.

(1) For HC1G66: V_M = 50%; V_I = GND to V_{CC} For HCT1G66: V_M = 1.3 V; V_I = GND to 3.0 V.

Fig.17 Input pulse definitions.

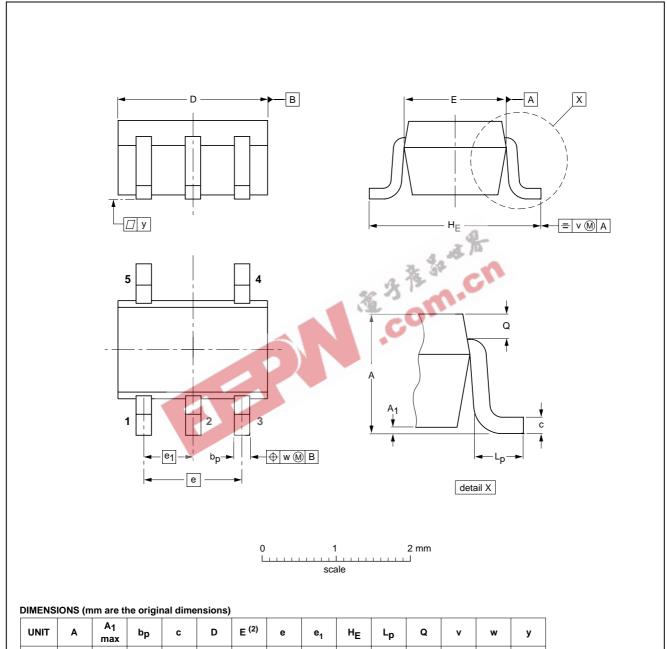
Bilateral switch

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PACKAGE OUTLINES

Plastic surface mounted package; 5 leads

SOT353



UNIT	Α	A ₁ max	bp	С	D	E ⁽²⁾	е	e ₁	HE	Lp	Q	٧	w	у
mm	1.1 0.8	0.1	0.30 0.20	0.25 0.10	2.2 1.8	1.35 1.15	1.3	0.65	2.2 2.0	0.45 0.15	0.25 0.15	0.2	0.2	0.1

OUTLINE	OUTLINE REFERENCES					ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT353			SC-88A			97-02-28	

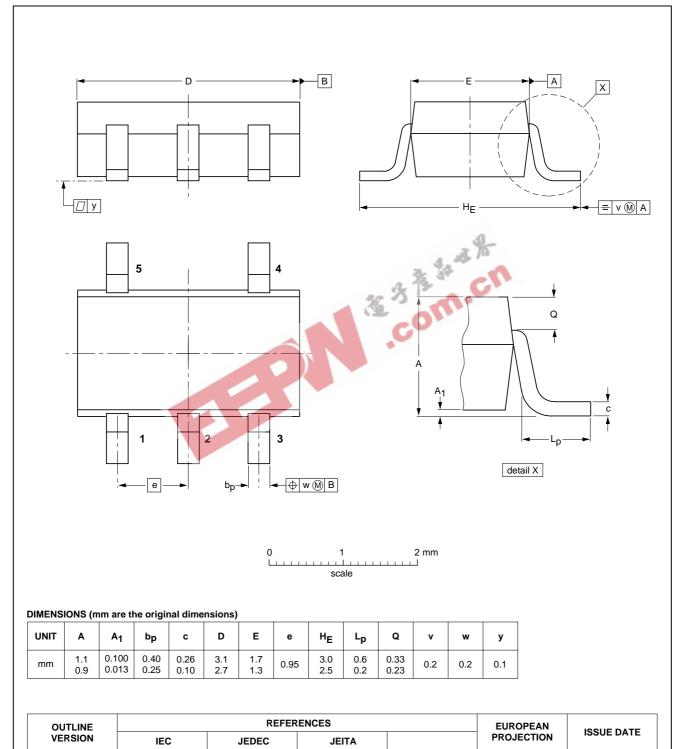
Bilateral switch

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02-04-16

Plastic surface mounted package; 5 leads

SOT753



SC-74A

SOT753

Bilateral switch

74HC1G66; 74HCT1G66

SOLDERING

Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "Data Handbook IC26; Integrated Circuit Packages" (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 220 °C for thick/large packages, and below 235 °C for small/thin packages.

Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

 For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 $^{\circ}$ C.

Bilateral switch

74HC1G66; 74HCT1G66

Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE ⁽¹⁾	SOLDERING METHOD			
PACKAGE	WAVE	REFLOW ⁽²⁾		
BGA, LBGA, LFBGA, SQFP, TFBGA, VFBGA	not suitable	suitable		
HBCC, HBGA, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable ⁽³⁾	suitable		
PLCC ⁽⁴⁾ , SO, SOJ	suitable	suitable		
LQFP, QFP, TQFP	not recommended ⁽⁴⁾⁽⁵⁾	suitable		
SSOP, TSSOP, VSO	not recommended ⁽⁶⁾	suitable		

Notes

- 1. For more detailed information on the BGA packages refer to the "(LF)BGA Application Note" (AN01026); order a copy from your Philips Semiconductors sales office.
- 2. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the "Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods".
- 3. These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- 4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- 5. Wave soldering is suitable for LQFP, TQFP and QFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- 6. Wave soldering is suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

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DATA SHEET STATUS

DATA SHEET STATUS(1)	PRODUCT STATUS ⁽²⁾	DEFINITIONS
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Notes

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Contact information

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